August 2015



FNA23060

600 V Motion SPM[®] 2 Series

Features

- UL Certified No. E209204 (UL1557)
- 600 V 30 A 3-Phase IGBT Inverter, Including Control ICs for Gate Drive and Protections
- Low-Loss, Short-Circuit-Rated IGBTs
- Very Low Thermal Resistance Using Al₂O₃ DBC Substrate
- Built-In Bootstrap Diodes and Dedicated Vs Pins Simplify PCB Layout
- Separate Open-Emitter Pins from Low-Side IGBTs for Three-Phase Current Sensing
- Single-Grounded Power Supply Supported
- Built-In NTC Thermistor for Temperature Monitoring and Management
- Adjustable Over-Current Protection via Integrated Sense-IGBTs
- Isolation Rating of 2500 Vrms / 1 min.

Applications

Motion Control - Industrial Motor (AC 200 V Class)

Related Resources

- AN-9121 Users Guide for 600V SPM[®] 2 Series
- AN-9076 Mounting Guide for New SPM[®] 2 Package
- AN-9079 Thermal Performance of Motion SPM[®] 2 Series by Mounting Torque

General Description

The FNA23060 is a Motion SPM[®] 2 module providing a fully-featured, high-performance inverter output stage for AC induction, BLDC, and PMSM motors. These modules integrate optimized gate drive of the built-in IGBTs to minimize EMI and losses, while also providing multiple on-module protection features: under-voltage lockouts, over-current shutdown, temperature sensing, and fault reporting. The built-in, high-speed HVIC requires only a single supply voltage and translates the incoming logic-level gate inputs to high-voltage, high-current drive signals to properly drive the module's internal IGBTs. Separate negative IGBT terminals are available for each phase to support the widest variety of control algorithms.



Figure 1. 3D Package Drawing (Click to Activate 3D Content)

Package Marking and Ordering Information

Device	Device Marking	Package	Packing Type	Quantity
FNA23060	FNA23060	SPMCA-A34	Rail	6

Intergrated Power Functions

• 600 V - 30 A IGBT inverter for three-phase DC / AC power conversion (refer to Figure 3)

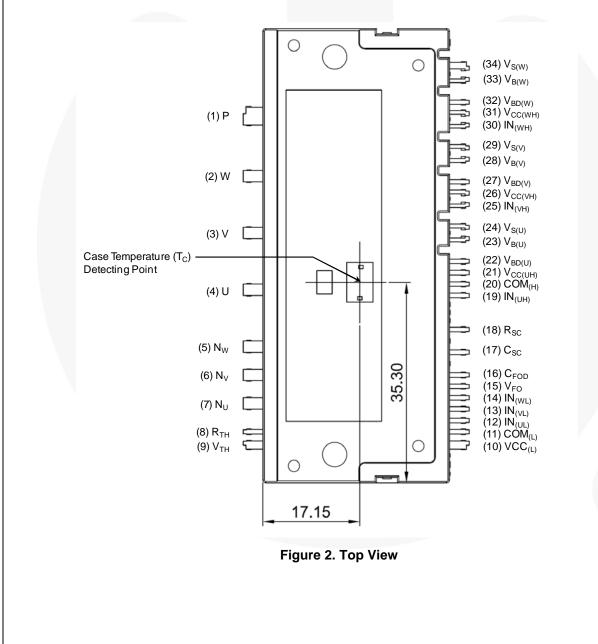
Intergrated Drive, Protection, and System Control Functions

 For inverter high-side IGBTs: gate-drive circuit, high-voltage isolated high-speed level-shifting control circuit, Under-Voltage Lock-Out Protection (UVLO), Available bestates size is given in Figures 5 and 15

Available bootstrap circuit example is given in Figures 5 and 15.

- For inverter low-side IGBTs: gate-drive circuit, Short-Circuit Protection (SCP) control circuit, Under-Voltage Lock-Out Protection (UVLO)
- · Fault signaling: corresponding to UV (low-side supply) and SC faults
- Input interface: active-HIGH interface, works with 3.3 / 5 V logic, Schmitt-trigger input

Pin Configuration



Pin Number	Pin Name	Pin Description
1	Р	Positive DC-Link Input
2	W	Output for W Phase
3	V	Output for V Phase
4	U	Output for U Phase
5	N _W	Negative DC-Link Input for W Phase
6	N _V	Negative DC-Link Input for V Phase
7	NU	Negative DC-Link Input for U Phase
8	R _{TH}	Series Resistor for Thermistor (Temperature Detection)
9	V _{TH}	Thermistor Bias Voltage
10	V _{CC(L)}	Low-Side Bias Voltage for IC and IGBTs Driving
11	COM _(L)	Low-Side Common Supply Ground
12	IN _(UL)	Signal Input for Low-Side U Phase
13	IN _(VL)	Signal Input for Low-Side V Phase
14	IN _(WL)	Signal Input for Low-Side W Phase
15	V _{FO}	Fault Output
16	C _{FOD}	Capacitor for Fault Output Duration Selection
17	C _{SC}	Capacitor (Low-Pass Filter) for Short-Circuit Current Detection Input
18	R _{SC}	Resistor for Short-Circuit Current Detection
19	IN _(UH)	Signal Input for High-Side U Phase
20	COM _(H)	High-Side Common Supply Ground
21	V _{CC(UH)}	High-Side Bias Voltage for U Phase IC
22	V _{BD(U)}	Anode of Bootstrap Diode for U Phase High-Side Bootstrap Circuit
23	V _{B(U)}	High-Side Bias Voltage for U Phase IGBT Driving
24	V _{S(U)}	High-Side Bias Voltage Ground for U Phase IGBT Driving
25	IN _(VH)	Signal Input for High-Side V Phase
26	V _{CC(VH)}	High-Side Bias Voltage for V Phase IC
27	V _{BD(V)}	Anode of Bootstrap Diode for V Phase High-Side Bootstrap Circuit
28	V _{B(V)}	High-Side Bias Voltage for V Phase IGBT Driving
29	V _{S(V)}	High-Side Bias Voltage Ground for V Phase IGBT Driving
30	IN _(WH)	Signal Input for High-Side W Phase
31	V _{CC(WH)}	High-Side Bias Voltage for W Phase IC
32	V _{BD(W)}	Anode of Bootstrap Diode for W Phase High-Side Bootstrap Circuit
33	V _{B(W)}	High-Side Bias Voltage for W Phase IGBT Driving
34	V _{S(W)}	High-Side Bias Voltage Ground for W Phase IGBT Driving

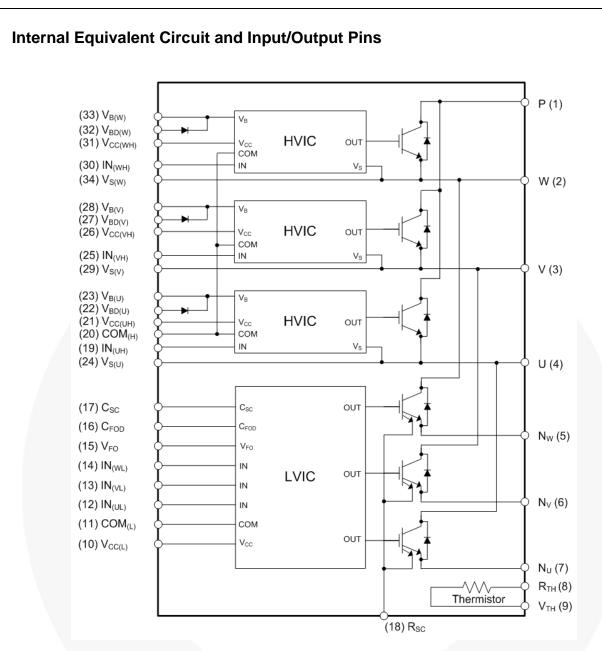


Figure 3. Internal Block Diagram

Notes:

- 1. Inverter high-side is composed of three normal-IGBTs, freewheeling diodes, and one control IC for each IGBT.
- 2. Inverter low-side is composed of three sense-IGBTs, freewheeling diodes, and one control IC for each IGBT. It has gate drive and protection functions.
- 3. Inverter power side is composed of four inverter DC-link input terminals and three inverter output terminals.

Absolute Maximum Ratings (T_J = 25°C, unless otherwise specified.)

Inverter Part

Symbol	Parameter	Conditions	Rating	Unit
V _{PN}	Supply Voltage	Applied between P - N _U , N _V , N _W	450	V
V _{PN(Surge)}	Supply Voltage (Surge)	Applied between P - N_U , N_V , N_W	500	V
V _{CES}	Collector - Emitter Voltage		600	V
± I _C	Each IGBT Collector Current	$T_C = 25^{\circ}C, T_J \le 150^{\circ}C$ (Note 4)	30	А
± I _{CP}	Each IGBT Collector Current (Peak)	$\begin{array}{l} T_{C} = 25^{\circ}C, \ T_{J} \leq 150^{\circ}C, \ Under \ 1 \ ms \ Pulse \\ Width \ (Note \ 4) \end{array}$	60	A
P _C	Collector Dissipation	$T_{C} = 25^{\circ}C$ per One Chip (Note 4)	121	W
TJ	Operating Junction Temperature		-40 ~ 150	°C

Control Part

Symbol	Parameter	Conditions	Rating	Unit
V _{CC}	Control Supply Voltage	Applied between V _{CC(H)} , V _{CC(L)} - COM	20	V
V _{BS}	High-Side Control Bias Voltage	Applied between V_B(U) - V_S(U), V_B(V) - V_S(V), V_B(W) - V_S(W)	20	V
V _{IN}	Input Signal Voltage	$\begin{array}{c c} \mbox{Applied between } IN_{(UH)}, \ IN_{(VH)}, \ IN_{(WH)}, \\ IN_{(UL)}, \ IN_{(VL)}, \ IN_{(WL)} - COM \end{array}$	-0.3 ~ V _{CC} +0.3	V
V _{FO}	Fault Output Supply Voltage	Applied between V _{FO} - COM	-0.3 ~ V _{CC} +0.3	V
I _{FO}	Fault Output Current	Sink Current at V _{FO} pin	2	mA
V _{SC}	Current Sensing Input Voltage	Applied between C _{SC} - COM	-0.3 ~ V _{CC} +0.3	V

Bootstrap Diode Part

Symbol	Parameter	Conditions	Rating	Unit
V _{RRM}	Maximum Repetitive Reverse Voltage		600	V
١ _F	Forward Current	T_C = 25°C, $T_J \leq 150^\circ C$ (Note 4)	1.0	A
I _{FP}	Forward Current (Peak)	T_{C} = 25°C, T_{J} \leq 150°C, Under 1 ms Pulse Width (Note 4)	2.0	A
TJ	Operating Junction Temperature		-40 ~ 150	°C

Total System

Symbol	Parameter	Conditions	Rating	Unit
V _{PN(PROT)}	Self-Protection Supply Voltage Limit (Short-Circuit Protection Capability)	V_{CC} = V_{BS} = 13.5 \sim 16.5 V, T_{J} = 150°C, V_{CES} < 600 V, Non-Repetitive, < 2 μs	400	V
т _с	Module Case Operation Temperature	See Figure 2	-40 ~ 125	°C
T _{STG}	Storage Temperature		-40 ~ 125	°C
V _{ISO}	Isolation Voltage	60 Hz, Sinusoidal, AC 1 Minute, Connection Pins to Heat Sink Plate	2500	V _{rms}

Thermal Resistance

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
R _{th(j-c)Q}	Junction-to-Case Thermal Resistance	Inverter IGBT Part (per 1 / 6 Module)	-	-	1.03	°C / W
R _{th(j-c)F}	(Note 5)	Inverter FWD Part (per 1 / 6 Module)	-	-	1.64	°C / W

Notes:

4. These values had been made an acquisition by the calculation considered to design factor.

5. For the measurement point of case temperature (T_C), please refer to Figure 2.

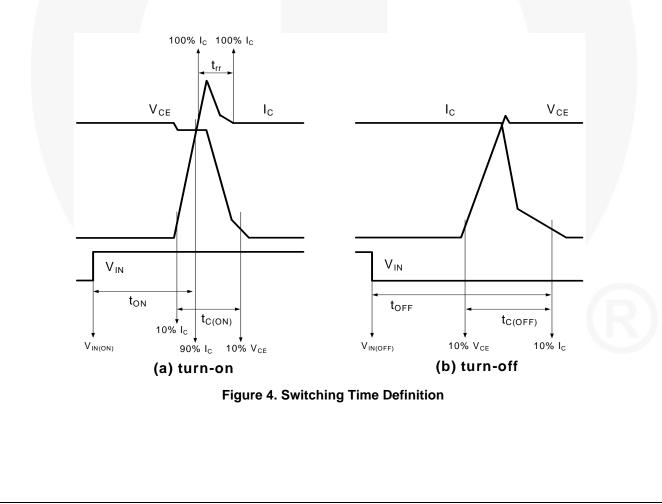
Electrical Characteristics (T_J = 25°C, unless otherwise specified.)

Inverter Part

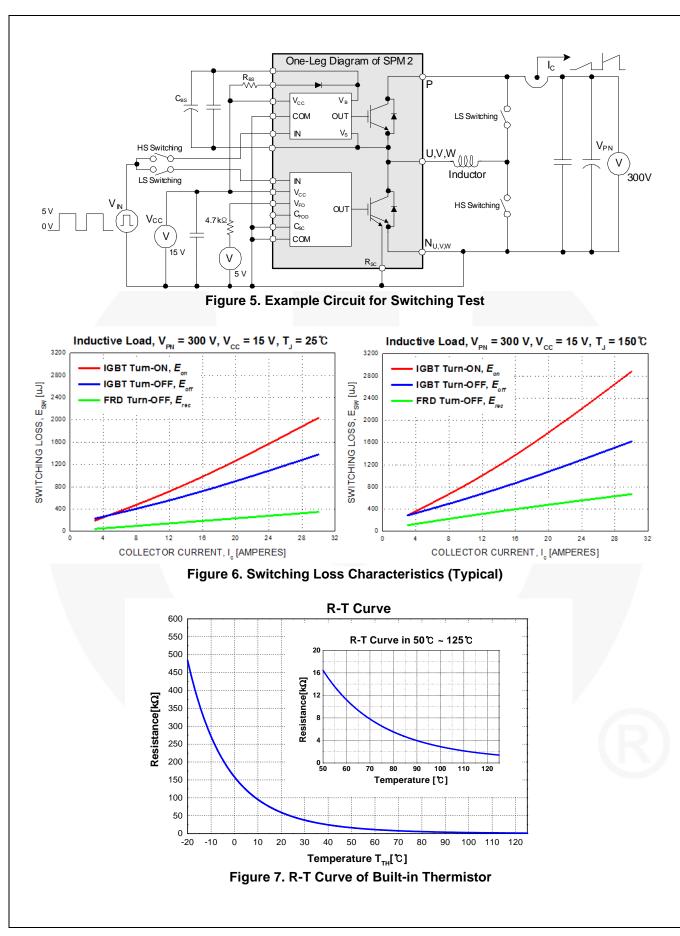
S	ymbol	Parameter	Conditions		Min.	Тур.	Max.	Unit
V	CE(SAT)	Collector - Emitter Saturation Voltage	$V_{CC} = V_{BS} = 15 V$ $V_{IN} = 5 V$	$I_{\rm C} = 30 \text{ A}, \text{ T}_{\rm J} = 25^{\circ} \text{C}$	-	1.50	2.10	V
	V _F	FWDi Forward Voltage	V _{IN} = 0 V	I _F = 30 A, T _J = 25°C	-	1.80	2.40	V
HS	t _{ON}	Switching Times	$V_{PN} = 300 \text{ V}, \text{ V}_{CC} = 15$	V, I _C = 30 A	0.80	1.30	1.90	μS
	t _{C(ON)}		$T_J = 25^{\circ}C$ $V_{IN} = 0 V \leftrightarrow 5 V$, Induc	tive Load	-	0.35	0.75	μS
	t _{OFF}		See Figure 5		-	1.05	1.65	μS
	t _{C(OFF)}		(Note 6)		-	0.15	0.55	μS
	t _{rr}				-	0.20	-	μS
LS	t _{ON}		$V_{PN} = 300 \text{ V}, \text{ V}_{CC} = 15$	V, I _C = 30 A	0.60	1.10	1.70	μS
	t _{C(ON)}		$T_J = 25^{\circ}C$ $V_{IN} = 0 V \leftrightarrow 5 V$, Induc	tive Load	-	0.30	0.70	μS
	t _{OFF}		See Figure 5		-	1.15	1.75	μS
	t _{C(OFF)}		(Note 6)		-	0.15	0.55	μS
	t _{rr}				-	0.20	-	μS
	I _{CES}	Collector - Emitter Leakage Current	$V_{CE} = V_{CES}$		-	-	5	mA

Note:

 t_{ON} and t_{OFF} include the propagation delay of the internal drive IC. t_{C(ON)} and t_{C(OFF)} are the switching times of IGBT under the given gate-driving condition internally. For the detailed information, *please see Figure 4*.



FNA23060 600 V Motion SPM® 2 Series



Bootstrap Di	Bootstrap Diode Part									
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit				
V _F	Forward Voltage	I _F = 1.0 A, T _J = 25°C	-	2.2	-	V				
t _{rr}	Reverse-Recovery Time	I_F = 1.0 A, dI_F / dt = 50 A / $\mu s,T_J$ = 25°C	-	80	-	ns				

Control Part

Symbol	Parameter	Conditions		Min.	Тур.	Max.	Unit
I _{QCCH}	Quiescent V _{CC} Supply Current	$V_{CC(UH,VH,WH)} = 15 V,$ $IN_{(UH,VH,WH)} = 0 V$	$\begin{array}{l} V_{CC(UH)} \text{-} COM_{(H)},\\ V_{CC(VH)} \text{-} COM_{(H)},\\ V_{CC(WH)} \text{-} COM_{(H)} \end{array}$	-	-	0.15	mA
I _{QCCL}		$V_{CC(L)} = 15 \text{ V}, \text{ IN}_{(UL,VL,WL)} = 0 \text{ V}$	V _{CC(L)} - COM _(L)	-	-	5.00	mA
I _{PCCH}	Operating V _{CC} Supply	$V_{CC(UH,VH,WH)} = 15$ V, $f_{PWM} = 20$ kHz, Duty = 50%, Applied to one PWM Signal Input for High-Side	$\begin{array}{l} V_{CC(UH)} \text{-} COM_{(H)},\\ V_{CC(VH)} \text{-} COM_{(H)},\\ V_{CC(WH)} \text{-} COM_{(H)} \end{array}$	·	-	0.30	mA
I _{PCCL}	Current	$V_{CC(L)}$ = 15V, f _{PWM} = 20 kHz, Duty = 50%, Applied to one PWM Signal Input for Low-Side	V _{CC(L)} - COM _(L)	-	-	9.00	mA
I _{QBS}	Quiescent V _{BS} Supply Current	V _{BS} = 15 V, IN _(UH, VH, WH) = 0 V	$V_{B(U)} - V_{S(U)}, V_{B(V)} - V_{S(V)}, V_{B(W)} - V_{S(W)}$	-	-	0.30	mA
I _{PBS}	Operating V _{BS} Supply Current	$V_{CC} = V_{BS} = 15 \text{ V}, f_{PWM} = 20 \text{ kHz},$ Duty = 50%, Applied to one PWM Signal Input for High-Side	$V_{B(U)} - V_{S(U)}, V_{B(V)} - V_{S(V)}, V_{B(W)} - V_{S(W)}$		-	6.50	mA
V _{FOH}	Fault Output Voltage	V_{CC} = 15 V, V_{SC} = 0 V, V_{FO} Circuit: 4.	V_{CC} = 15 V, V_{SC} = 0 V, V_{FO} Circuit: 4.7 k Ω to 5 V Pull-up		-	-	V
V _{FOL}	V_{CC} = 15 V, V_{SC} = 1 V, V_{FO} Circuit: 4.7 k Ω to 5 V Pull-		7 k Ω to 5 V Pull-up	-	-	0.5	V
I _{SEN}	Sensing Current of Each Sense IGBT	$V_{CC} = 15 \text{ V}, V_{IN} = 5 \text{ V}, R_{SC} = 0 \Omega, \text{No}$ $I_C = 30 \text{ A}$ Connection of Shunt Resistor at $N_{U,V,W}$ Terminal		-	19	-	mA
V _{SC(ref)}	Short Circuit Trip Level	V _{CC} = 15 V (Note 7)	C _{SC} - COM _(L)	0.43	0.50	0.57	V
I _{SC}	Short Circuit Current Level for Trip	R_{SC} = 20 Ω (± 1%), No Connection of N _{U,V,W} Terminal (Note 7)	of Shunt Resistor at	-	60	-	A
UV _{CCD}	Supply Circuit Under-	Detection Level		10.3	-	12.8	V
UV _{CCR}	Voltage Protection	Reset Level		10.8	-	13.3	V
UV _{BSD}		Detection Level		9.5	-	12.0	V
UV _{BSR}		Reset Level		10.0	-	12.5	V
t _{FOD}	Fault-Out Pulse Width	C _{FOD} = Open	(Note 8)	50	-	-	μS
		C _{FOD} = 2.2 nF		1.7	-	-	ms
V _{IN(ON)}	ON Threshold Voltage	Applied between IN(UH, VH, WH) - COI	$M_{(H)}$, $IN_{(UL, VL, WL)}$ -	-	-	2.6	V
V _{IN(OFF)}	OFF Threshold Voltage	COM _(L)		0.8	-	-	V
R _{TH}	Resistance of	at T _{TH} = 25°C	See Figure 7	-	47	-	kΩ
	Thermistor	at T _{TH} = 100°C	(Note 9)	-	2.9	- /	kΩ

Notes:

 Short-circuit current protection functions only at the low-sides because the sense current is divided from main current at low-side IGBTs. Inserting the shunt resistor for monitoring the phase current at N_U, N_V, N_W terminal, the trip level of the short-circuit current is changed.

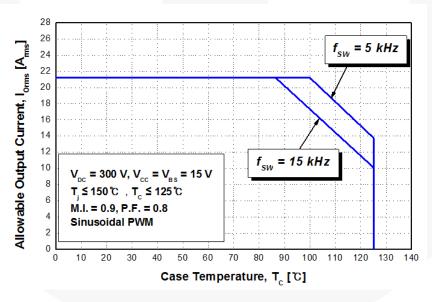
8. The fault-out pulse width t_{FOD} depends on the capacitance value of C_{FOD} according to the following approximate equation : $t_{FOD} = 0.8 \times 10^6 \times C_{FOD}$ [s].

9. T_{TH} is the temperature of thermistor itself. To know case temperature (T_C), conduct experiments considering the application.

Symbol	Devenueter	Conditions	Value			110:4
	Parameter	Conditions	Min.	Тур.	Max.	Unit
V _{PN}	Supply Voltage	Applied between P - N _U , N _V , N _W	-	300	400	V
V _{CC}	Control Supply Voltage	Applied between V _{CC(UH, VH, WH)} - COM _(H) , V _{CC(L)} - COM _(L)	14.5	15.0	16.5	V
V_{BS}	High-Side Bias Voltage	Applied between $V_{B(U)}$ - $V_{S(U)}, \ V_{B(V)}$ - $V_{S(V)}, \ V_{B(W)}$ - $V_{S(W)}$	13.5	15.0	18.5	V
dV _{CC} / dt, dV _{BS} / dt	Control Supply Variation		-1	-	1	V / με
t _{dead}	Blanking Time for Preventing Arm - Short	For Each Input Signal	1.5	-	-	μS
f _{PWM}	PWM Input Signal	$-40^\circ C \leq T_C \leq 125^\circ C, \ -40^\circ C \leq T_J \leq 150^\circ C$	-	-	20	kHz
V_{SEN}	Voltage for Current Sensing	Applied between N_U , N_V , N_W - $COM_{(H, L)}$ (Including Surge Voltage)	-5		5	V
PW _{IN(ON)}	Minimun Input Pulse	V_{CC} = V_{BS} = 15 V, I_{C} \leq 60 A, Wiring Inductance	2.0	-	-	μS
PW _{IN(OFF)}	Width	between N _{U, V, W} and DC Link N < 10nH (Note 10)	2.0	-	-]
Тj	Junction Temperature		-40	-	150	°C

Note:

10. This product might not make right output response if input pulse width is less than the recommanded value.





Note:

11. This allowable output current value is the reference data for the safe operation of this product. This may be different from the actual application and operating condition.

Parameter	Conditions		Min.	Тур.	Max.	Unit
Device Flatness	See Figure 9	ee Figure 9		-	+200	μm
Mounting Torque	Mounting Screw: M4	Recommended 1.0 N • m	0.9	1.0	1.5	N • m
	See Figure 10	Recommended 10.1 kg • cm	9.1	10.1	15.1	kg • cm
Terminal Pulling Strength	Load 19.6 N		10	-	-	S
Terminal Bending Strength	Load 9.8 N, 90 degrees E	Bend	2	-	-	times
Weight			-	50	-	g

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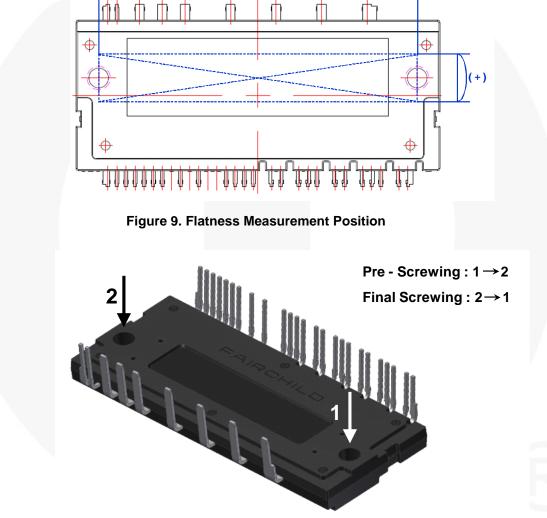
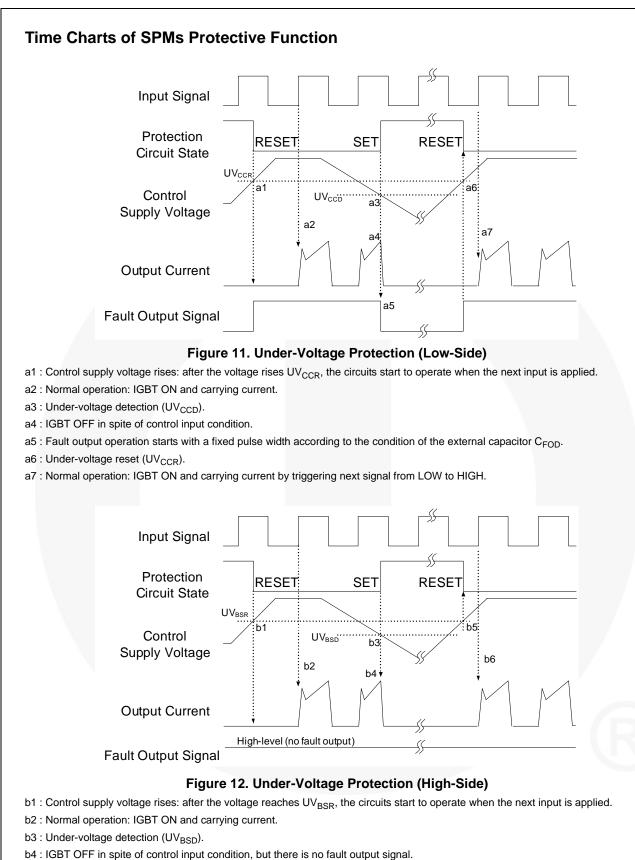


Figure 10. Mounting Screws Torque Order

Notes:

- 12. Do not over torque when mounting screws. Too much mounting torque may cause DBC cracks, as well as bolts and AI heat-sink destruction.
- 13. Avoid one-sided tightening stress. Figure 10 shows the recommended torque order for the mounting screws. Uneven mounting can cause the DBC substrate of package to be damaged. The pre-screwing torque is set to 20 ~ 30% of maximum torque rating.



- b5 : Under-voltage reset (UV_{BSR}).
- b6 : Normal operation: IGBT ON and carrying current by triggering next signal from LOW to HIGH.

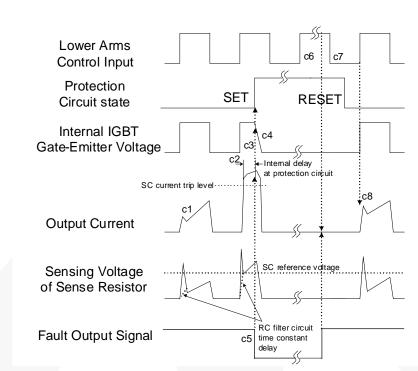


Figure 13. Short-Circuit Current Protection (Low-Side Operation only)

(with the external sense resistance and RC filter connection)

c1 : Normal operation: IGBT ON and carrying current.

c2 : Short-circuit current detection (SC trigger).

c3 : All low-side IGBTs gate are hard interrupted.

c4 : All low-side IGBTs turn OFF.

c5 : Fault output operation starts with a fixed pulse width according to the condition of the external capacitor C_{FOD}.

c6 : Input HIGH: IGBT ON state, but during the active period of fault output, the IGBT doesn't turn ON.

c7 : Fault output operation finishes, but IGBT doesn't turn on until triggering the next signal from LOW to HIGH.

c8 : Normal operation: IGBT ON and carrying current.

Input/Output Interface Circuit

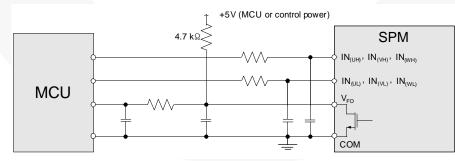


Figure 14. Recommended MCU I/O Interface Circuit

Note:

14. RC coupling at each input might change depending on the PWM control scheme used in the application and the wiring impedance of the application's printed circuit board. The input signal section of the Motion SPM 2 product integrates 5 kΩ (typ.) pull-down resistor. Therefore, when using an external filtering resistor, please pay attention to the signal voltage drop at input terminal.

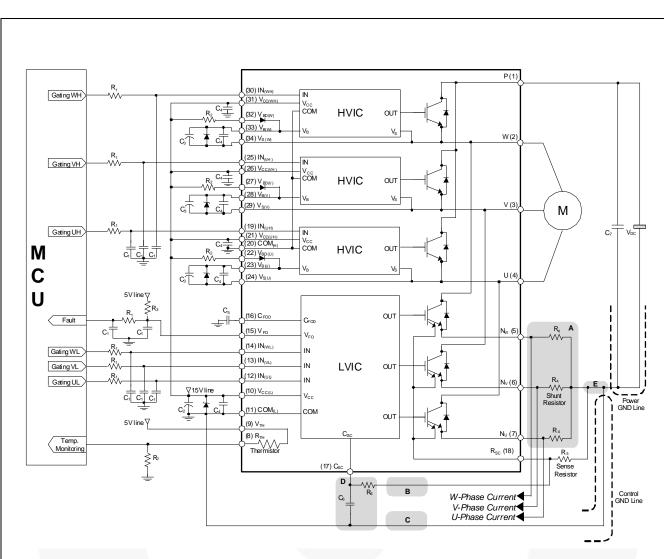
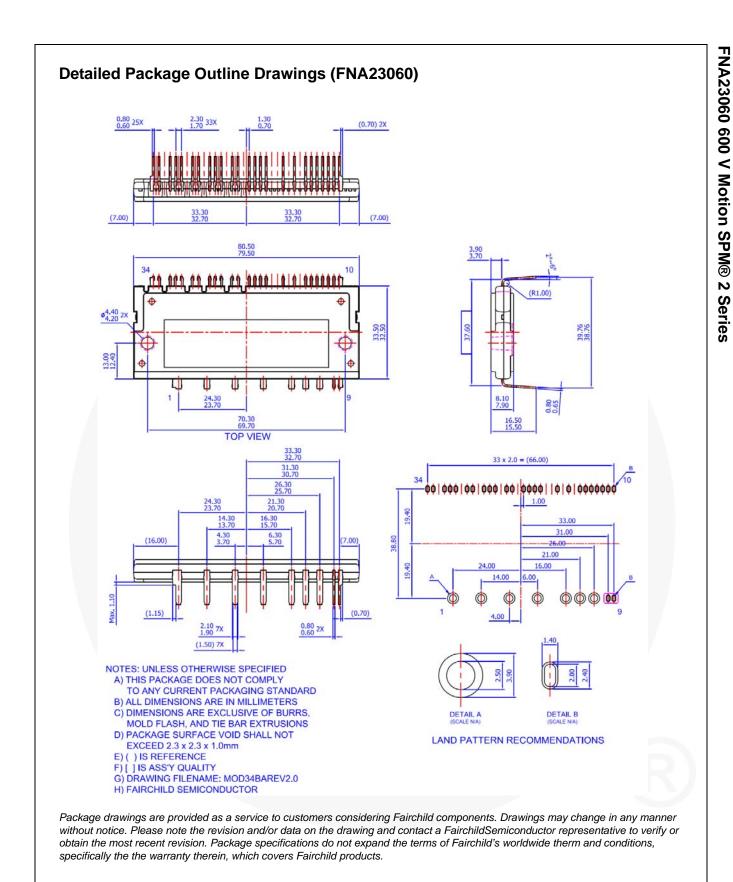


Figure 15. Typical Application Circuit

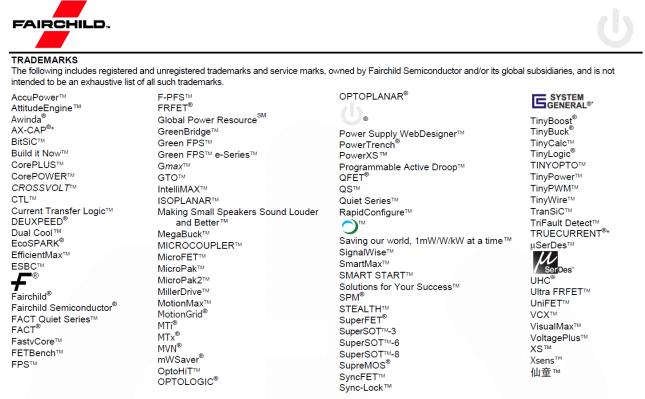
Notes:

- 15. To avoid malfunction, the wiring of each input should be as short as possible (less than 2 3 cm).
- 16. V_{FO} output is an open-drain type. This signal line should be pulled up to the positive side of the MCU or control power supply with a resistor that makes I_{FO} up to 2 mA. Please refer to Figure 14.
- 17. Fault out pulse width can be adjust by capacitor C_5 connected to the $\mathrm{C}_{\mathrm{FOD}}$ terminal.
- 18. Input signal is active-HIGH type. There is a 5 k Ω resistor inside the IC to pull-down each input signal line to GND. RC coupling circuits should be adopted for the prevention of input signal oscillation. R₁C₁ time constant should be selected in the range 50 ~ 150 ns (recommended R₁ = 100 Ω , C₁ = 1 nF).
- 19. Each wiring pattern inductance of point A should be minimized (recommend less than 10 nH). Use the shunt resistor R₄ of surface mounted (SMD) type to reduce wiring inductance. To prevent malfunction, wiring of point E should be connected to the terminal of the shunt resistor R₄ as close as possible.
- 20. To insert the shunt resistor to measure each phase current at N_U, N_V, N_W terminal, it makes to change the trip level I_{SC} about the short-ciruit current.
- 21. To prevent errors of the protection function, the wiring of points B, C, and D should be as short as possible. The wiring of B between C_{SC} filter and R_{SC} terminal should be divided at the point that is close to the terminal of sense resistor R₅.
- 22. For stable protection function, use the sense resistor ${\sf R}_5$ with resistance variation within 1% and low inductance value.
- 23. In the short-circuit protection circuit, select the R₆C₆ time constant in the range 1.0 ~ 1.5 μs. R₆ should be selected with a minimum of 10 times larger resistance than sense resistor R₅. Do enough evaluaiton on the real system because short-circuit protection time may vary wiring pattern layout and value of the R₆C₆ time constant.
- 24. Each capacitor should be mounted as close to the pins of the Motion SPM® 2 product as possible.
- 25. To prevent surge destruction, the wiring between the smoothing capacitor C₇ and the P & GND pins should be as short as possible. The use of a high-frequency non-inductive capacitor of around 0.1 ~ 0.22 μF between the P & GND pins is recommended.
- 26. Relays are used in most systems of electrical equipments in industrial application. In these cases, there should be sufficient distance between the MCU and the relays.
- 27. The Zener diode or transient voltage suppressor should be adapted for the protection of ICs from the surge destruction between each pair of control supply terminals (recommanded Zener diode is 22 V / 1 W, which has the lower Zener impedance characteristic than about 15 Ω).
- 28. C_2 of around seven times larger than bootstrap capacitor C_3 is recommended.
- 29. Please choose the electrolytic capacitor with good temperature characteristic in C₃. Choose 0.1 ~ 0.2 µF R-category ceramic capacitors with good temperature and frequency characteristics in C₄.



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http://www.fairchildsemi.com/dwg/MO/MOD34BA.pdf



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Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.fairchildsemi.com, under Terms of Use

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufacturers of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed applications, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handling and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address any warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

PRODUCT STATUS DEFINITIONS

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.